Sheet <u>1</u> of <u>1</u>									
Form PTO-1449		U.S. DEPARTME	NT OF COMMERC	CE ATTY. DOCKE	ATTY. DOCKET NO.		SERIAL NO.		
(REV. 8-83) PATENT AND TRADEM			ADEMARK OFFIC	ľ			Not Yet Assigned		
INFO	ON A TIO	N DISCLOSUR	E CITATION	2001 P 119	2001 P 11914 US		1	<b>[6]</b>	
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	(Use se	veral sheets if nece	essary)						
			MEASUREMENT	APPLICANT	APPLICANT Chen et al.		EXAMINER Not Yet Assigned		
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			U. :	S. PATENT DOC	UMENTS				
Examiner INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	1	G DATE ROPRIATE	
p2		4,840,487	Jun. 20, 1989	Noguchi et al.	356	355			
RR		5,691,540	Nov. 25, 1997	Halle et al.	250	372			
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			FOREIGN PA	TENT DOCUMEN	NTS				
	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION		
							YES	NO	
		OTHER DOCUM	IENTS (Including )	Autnor, Title, Date	, Pertinent Pag 	ies, Etc.)			

\*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

**DATE CONSIDERED** 

4-24-02

**EXAMINER** 

RAZVIS